

MITSUBISHI LSTTLs M74LS247P

BCD-TO-7-SEGMENT DECODER/DRIVER(ACTIVE-LOW OUTPUT)

DESCRIPTION

The M74LS247P is a semiconductor integrated circuit provided with BCD-to-7-segment decoder/driver function and open collector outputs.

FEATURES

- Suitable for 7-segment display element lighting
- \overline{RBI} input and $\overline{BI}/\overline{RBO}$ outputs for zero suppression
- \overline{LT} input for lamp testing
- $\overline{BI}/\overline{RBO}$ input for extinguishing all segments
- Open collector outputs
- Wide operating temperature range ($T_a = -20 \sim +75^\circ\text{C}$)

APPLICATION

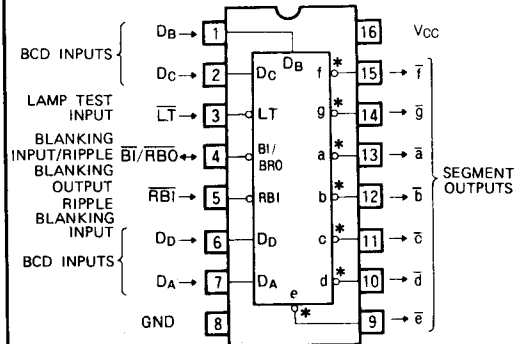
General purpose, for use in industrial and consumer equipment.

FUNCTIONAL DESCRIPTION

When a number is specified in BCD code for BCD inputs D_A , D_B , D_C and D_D , segment outputs $\overline{a} \sim \overline{g}$ are set low in accordance with that number. By connecting the 7-segment display element to each of the outputs, the character indicated on the display character can be displayed. $\overline{a} \sim \overline{g}$ are open collector outputs with a breakdown voltage of not less than 15V and a low-level output current of 24mA, thereby making it possible to drive directly a 7-segment LED for the display of anode-common numbers.

Suppression of the unnecessary high-order zeroes is possible by setting the highest order \overline{RBI} ripple blanking input low and connecting ripple blanking output $\overline{BI}/\overline{RBO}$ to the next-level \overline{RBI} for each of the digits. Refer to the M74LS47P for the application example.

PIN CONFIGURATION (TOP VIEW)



*: OPEN COLLECTOR OUTPUTS

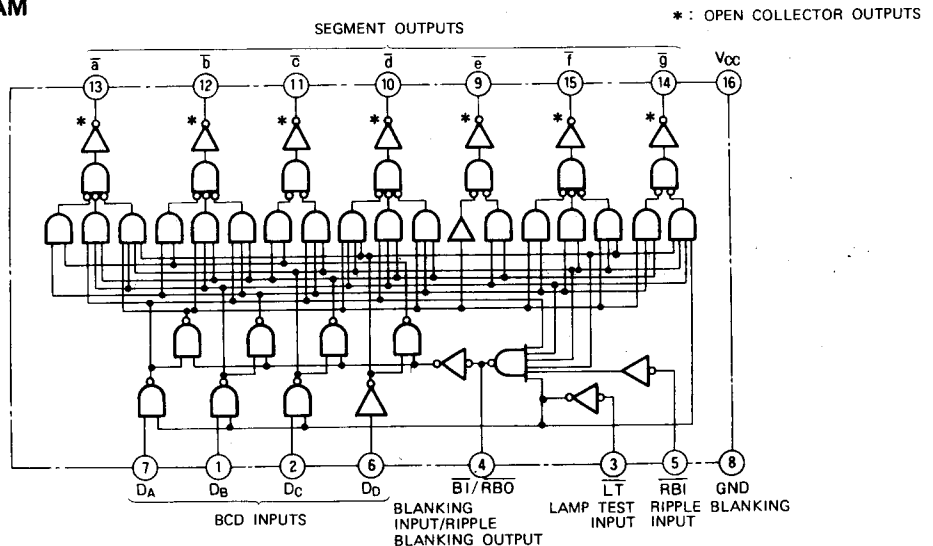
Outline 16P4

By setting blanking input $\overline{BI}/\overline{RBO}$ low, outputs $\overline{a} \sim \overline{g}$ are set high and the display element is extinguished irrespective of the status of the other inputs. Since $\overline{BI}/\overline{RBO}$ serves as both an input and output pin, only ICs with open collector outputs can be connected to this pin.

By setting lamp test input \overline{LT} low, $\overline{a} \sim \overline{g}$ are set low irrespective of the status of $\overline{BI}/\overline{RBO}$, D_A , D_B , D_C and D_D , all the segments in the display element are lighted and each segment can be tested. Refer to M74LS47P for the $\overline{BI}/\overline{RBO}$ and $\overline{a} \sim \overline{g}$ circuits.

The only difference between the M74LS247P and M74LS47P is the configuration of the 6 and 9 numerals.

BLOCK DIAGRAM



BCD-TO-7-SEGMENT DECODER/DRIVER(ACTIVE-LOW OUTPUT)

FUNCTION TABLE (Note 1)

Decimal number or function	\overline{LT}	\overline{RBI}	D_D	D_C	D_B	D_A	$\overline{BI}/\overline{RBO}$	\overline{a}	\overline{b}	\overline{c}	\overline{d}	\overline{e}	\overline{f}	\overline{g}	Note
0	H	H	L	L	L	L		H	L	L	L	L	L	L	
1	H	X	L	L	L	H		H	H	L	L	H	H	H	
2	H	X	L	L	H	L		H	L	L	H	L	L	H	
3	H	X	L	L	H	H		H	L	L	L	L	H	H	
4	H	X	L	H	L	L		H	H	L	L	H	H	L	
5	H	X	L	H	L	H		H	L	H	L	L	H	L	
6	H	X	L	H	H	L		H	L	H	L	L	L	L	
7	H	X	L	H	H	H		H	L	L	L	H	H	H	(1)
8	H	X	H	L	L	L		H	L	L	L	L	L	L	
9	H	X	H	L	L	H		H	L	L	L	L	H	L	
10	H	X	H	L	H	L		H	H	H	H	L	L	H	
11	H	X	H	L	H	H		H	H	H	L	L	H	H	
12	H	X	H	H	L	L		H	H	L	H	H	H	L	
13	H	X	H	H	L	H		H	L	H	H	L	H	L	
14	H	X	H	H	H	L		H	H	H	H	L	L	L	
15	H	X	H	H	H	H		H	H	H	H	H	H	H	
Blanking	X	X	X	X	X	X	L		H	H	H	H	H	H	(2)
Ripple blanking	H	L	L	L	L	L		L	H	H	H	H	H	H	(3)
Lamp test	L	X	X	X	X	X		H	L	L	L	L	L	L	(4)

Note 1. (1) \overline{LT} is normally kept in high.

\overline{RBI} is kept open or in high with a decimal 0 output.

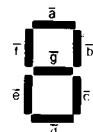
(2) When $\overline{BI}/\overline{RBO}$ is low, all the segment outputs are high irrespective of the status of the other inputs.

(3) All the segment outputs are set high and $\overline{BI}/\overline{RBO}$ is set low when \overline{RBI} , D_A , D_B , D_C and D_D are set low with \overline{LT} high.

(4) When \overline{LT} is low, all the segment outputs are low.

X: Irrelevant

DEFINITION OF SEGMENTS



CHARACTERS DISPLAYED

Decimal number	0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15
Character	0	1	2	3	4	5	6	7	8	9	c	3	4	5	6	

ABSOLUTE MAXIMUM RATINGS (Ta = -20 ~ +75°C, unless otherwise noted)

Symbol	Parameter	Conditions	Limits	Unit
V_{CC}	Supply voltage		-0.5 ~ +7	V
V_I	Input voltage	Input $\overline{BI}/\overline{RBO}$	-0.5 ~ V_{CC}	V
		Other inputs	-0.5 ~ +15	V
V_O	Output voltage	Output $\overline{BI}/\overline{RBO}$	-0.5 ~ V_{CC}	V
		Other outputs	-0.5 ~ +15	V
$I_{O(peak)}$	Output current	$t_w \leq 1ms, duty\ cycle \leq 10\%$	200	mA
I_O	Output current	High-level state	1	mA
T_{opr}	Operating free-air ambient temperature range		-20 ~ +75	°C
T_{sig}	Storage temperature range		-65 ~ +150	°C

RECOMMENDED OPERATING CONDITIONS (Ta = -20 ~ +75°C, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min	Typ	Max	
V_{CC}	Supply voltage	4.75	5	5.25	V
I_{OH}	High-level output current, outputs a ~ g	$V_{OH} = 15V$	0	250	μA
I_{OH}	High-level output current, output $\overline{BI}/\overline{RBO}$	$V_{OH} \geq 2.4V$	0	-50	μA
I_{OL}	Low-level output current, outputs a ~ g	$V_{OL} \leq 0.4V$	0	12	mA
		$V_{OL} \leq 0.5V$	0	24	mA
I_{OL}	Low-level output current, output $\overline{BI}/\overline{RBO}$	$V_{OL} \leq 0.4V$	0	1.6	mA
		$V_{OL} \leq 0.5V$	0	3.2	mA

BCD-TO-7-SEGMENT DECODER/DRIVER(ACTIVE-LOW OUTPUT)

ELECTRICAL CHARACTERISTICS ($T_a = -20 \sim +70^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit	
			Min	Typ *	Max		
V_{IH}	High-level input voltage		2			V	
V_{IL}	Low-level input voltage				0.8	V	
V_{IC}	Input clamp voltage	$V_{CC} = 4.75\text{V}$, $I_{IC} = -18\text{mA}$			-1.5	V	
V_{OH}	High-level output voltage, output $\overline{\text{BI}}/\overline{\text{RB0}}$	$V_{CC} = 4.75\text{V}$				V	
I_{OH}	High-level output current, outputs $\overline{\text{a}} \sim \overline{\text{g}}$	$V_1 = 0.8\text{V}$, $V_I = 2\text{V}$	$I_{OH} = -50\mu\text{A}$	2.4	4.2	μA	
V_{OL}	Low-level output voltage	Outputs $\overline{\text{a}} \sim \overline{\text{g}}$	$I_{OL} = 12\text{mA}$		0.25	0.4	V
			$I_{OL} = 24\text{mA}$		0.35	0.5	V
			$I_{OL} = 1.6\text{mA}$		0.25	0.4	V
			$I_{OL} = 3.2\text{mA}$		0.35	0.5	V
I_{IH}	High-level input current, except input $\overline{\text{BI}}/\overline{\text{RB0}}$	$V_{CC} = 5.25\text{V}$, $V_I = 2.7\text{V}$			20	μA	
		$V_{CC} = 5.25\text{V}$, $V_I = 10\text{V}$			0.1	mA	
I_{IL}	Low-level input current	Input $\overline{\text{BI}}/\overline{\text{RB0}}$	$V_{CC} = 5.25\text{V}$, $V_I = 0.4\text{V}$			-1.2	mA
		Other inputs				-0.4	mA
I_{OS}	Short-circuit output current, output $\overline{\text{BI}}/\overline{\text{RB0}}$	$V_{CC} = 5.25\text{V}$, $V_O = 0\text{V}$	-0.3		-2	mA	
I_{CC}	Supply current	$V_{CC} = 5.25\text{V}$ (Note 2)		7	13	mA	

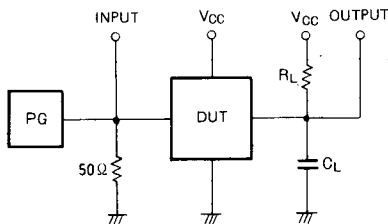
* : All typical values are at $V_{CC} = 5\text{V}$, $T_a = 25^\circ\text{C}$.

Note 2. I_{CC} is measured with all inputs at 4.5V.

SWITCHING CHARACTERISTICS ($V_{CC} = 5\text{V}$, $T_a = 25^\circ\text{C}$, unless otherwise noted)

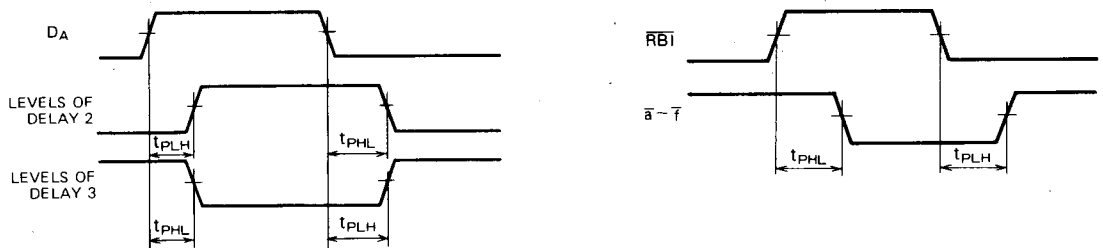
Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
t_{PLH}	Low-to-high-level, high-to-low-level output propagation time, from input D_A to outputs $\overline{\text{a}} \sim \overline{\text{g}}$	$R_L = 665\Omega$ $C_L = 15\text{pF}$ (Note 3)		35	100	ns
t_{PHL}				30	100	ns
t_{PLH}	Low-to-high-level, high-to-low-level output propagation time, from input $\overline{\text{RB1}}$ to outputs $\overline{\text{a}} \sim \overline{\text{f}}$			50	100	ns
t_{PHL}				45	100	ns

Note 3: Measurement circuit



- (1) The pulse generator (PG) has the following characteristics:
PRR=1MHz, $t_r=6\text{ns}$, $t_f=6\text{ns}$, $t_w=500\text{ns}$, $V_p=3\text{V}_{p-p}$, $Z_0=50\Omega$.
- (2) C_L includes probe and jig capacitance

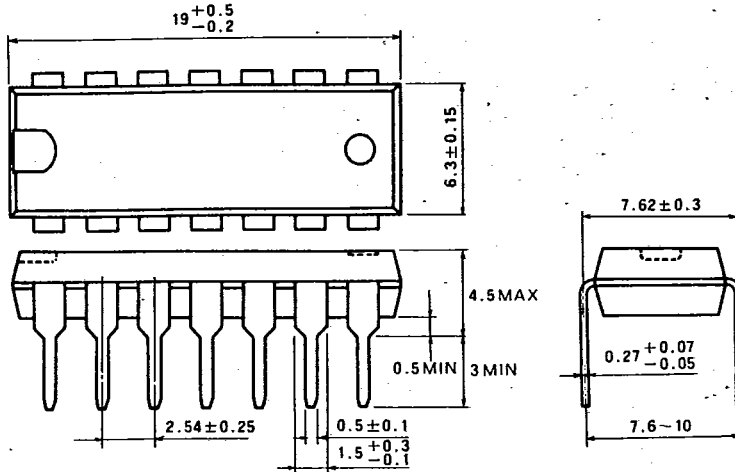
TIMING DIAGRAM (Reference level = 1.3V)



T-90-20

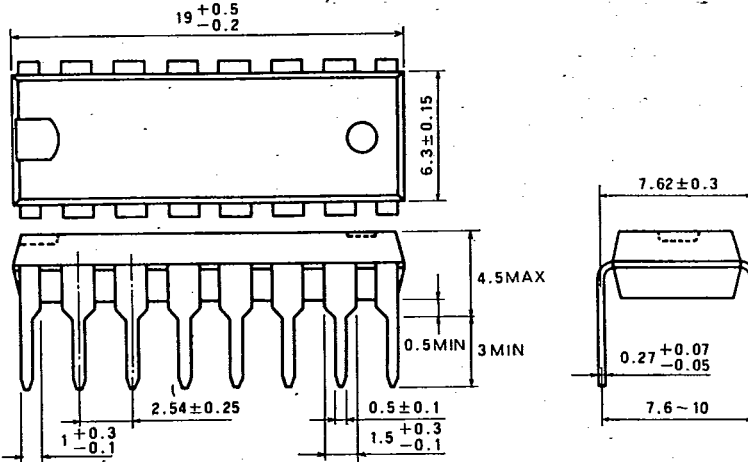
TYPE 14P4 14-PIN MOLDED PLASTIC DIL

Dimension in mm



TYPE 16P4 16-PIN MOLDED PLASTIC DIL

Dimension in mm



TYPE 20P4 20-PIN MOLDED PLASTIC DIL

Dimension in mm

